Supplementary Information

Enhancement and Modulation of Valley Polarization in Janus CrSSe

with Internal and External Electric Fields

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	Ι	II	III	IV	V	VI
CrSe2	48	42	30	28	17	32
CrS2	13	19	15	14	12	22
S	18	8	13	18	23	23
Se	29	80	60	71	2	32

Table S1 Valley polarization Values of different materials and stacking conditions



Fig. S1 Structure of CrSSe/MnO2 under different stacks on the contacting interface is S atom.



Fig. S2 Band structures corresponding to each structure in the Fig. S1.

Materials	Berry curvature (Bohr ²)		
SnS ¹	4		
TcIrGe ₂ S ₆ ²	9.48		
CrSSe (our materials)	30.83		
MoS ₂ ³	62		
TiBrI ⁴	106		

Table S2 Berry curvature of different materials in papers.



Fig. S3 The layer-resolved band structure of CrSSe/MnO2.



Fig. S4 The plot of charge density difference under different magnitudes of applied electric field.

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